

<b>Notice of References Cited</b>	Application/Control No. 10/825,171		Applicant(s)/Patent Under Reexamination MARTINEAU ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,297,253 A	03-1994	Meisel, Leslie M.	715/854
*	B	US-5,446,838 A	08-1995	Kimelman, Douglas N.	715/764
*	C	US-5,479,600 A	12-1995	Wroblewski et al.	715/787
*	D	US-5,526,481 A	06-1996	Parks et al.	715/784
*	E	US-5,550,969 A	08-1996	Torres et al.	715/787
*	F	US-5,550,559 A	08-1996	Isensee et al.	345/684
*	G	US-5,745,718 A	04-1998	Cline et al.	715/777
*	H	US-5,751,965 A	05-1998	Mayo et al.	709/224
*	I	US-5,784,058 A	07-1998	LaStrange et al.	715/738
*	J	US-5,815,155 A	09-1998	Wolfston, Jr., James H.	715/855
*	K	US-5,852,439 A	12-1998	Musgrove et al.	715/764
*	L	US-5,844,560 A	12-1998	Crutcher et al.	715/840
*	M	US-5,848,373 A	12-1998	DeLorme et al.	701/200

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,910,803 A	06-1999	Grau et al.	715/734
*	B	US-5,977,972 A	11-1999	Bates et al.	715/786
*	C	US-6,020,889 A	02-2000	Tarbox et al.	715/736
*	D	US-6,057,840 A	05-2000	Durrani et al.	715/786
*	E	US-6,073,136 A	06-2000	Bertram et al.	1/1
*	F	US-6,101,498 A	08-2000	Scaer et al.	1/1
*	G	US-6,147,683 A	11-2000	Martinez et al.	715/786
*	H	US-6,195,679 B1	02-2001	Bauersfeld et al.	709/203
*	I	US-6,211,877 B1	04-2001	Steele et al.	715/804
*	J	US-6,222,541 B1	04-2001	Bates et al.	715/786
*	K	US-6,268,854 B1	07-2001	Borden et al.	715/786
*	L	US-6,271,845 B1	08-2001	Richardson, David E	715/764
*	M	US-6,300,967 B1	10-2001	Wagner et al.	715/784

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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#### NON-PATENT DOCUMENTS

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,297,823 B1	10-2001	Bharali et al.	715/788
*	B	US-2001/0042118 A1	11-2001	Miyake et al.	709/223
*	C	US-6,334,145 B1	12-2001	Adams et al.	709/217
*	D	US-6,366,302 B1	04-2002	Crosby et al.	715/786
*	E	US-6,388,686 B1	05-2002	Hetherington et al.	715/810
*	F	US-6,408,316 B1	06-2002	Himmel et al.	715/206
*	G	US-6,411,275 B1	06-2002	Hedberg, Anders	345/156
*	H	US-2002/0091732 A1	07-2002	Pedro, Justin E.	707/505
*	I	US-6,452,597 B1	09-2002	Goldberg et al.	345/472
*	J	US-6,460,058 B2	10-2002	Koppolu et al.	715/738
*	K	US-2002/0152267 A1	10-2002	Lennon, Alison J.	709/203
*	L	US-6,483,525 B1	11-2002	Tange, Akira	715/765
*	M	US-2003/0011641 A1	01-2003	Totman et al.	345/810

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
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#### NON-PATENT DOCUMENTS

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0018665 A1	01-2003	Dovin et al.	707/513
*	B	US-6,593,944 B1	07-2003	Nicolas et al.	715/744
*	C	US-6,590,594 B2	07-2003	Bates et al.	715/784
*	D	US-2003/0172078 A1	09-2003	Stumpf, Dirk	707/100
*	E	US-6,621,532 B1	09-2003	Mandt, Brenda Lynn	348/841
*	F	US-2003/0197738 A1	10-2003	Beit-Zuri et al.	345/786
*	G	US-6,683,626 B1	01-2004	Abellera, Suzanne L.	715/785
*	H	US-2004/0014013 A1	01-2004	Diesel et al.	434/118
*	I	US-2004/0075693 A1	04-2004	Moyer et al.	345/810
*	J	US-2004/0093562 A1	05-2004	Diorio et al.	715/513
*	K	US-6,751,777 B2	06-2004	Bates et al.	715/206
*	L	US-6,781,609 B1	08-2004	Barker et al.	715/760
*	M	US-6,773,347 B1	08-2004	Marshall et al.	463/25

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
	X	

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	Examiner STEVEN B. THERIAULT		Art Unit 2179	Page 5 of 5

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,771,284 B1	08-2004	Anderson et al.	715/705
*	B	US-6,788,316 B1	09-2004	Ma et al.	715/760
*	C	US-2004/0207666 A1	10-2004	Hally et al.	345/854
*	D	US-6,857,105 B1	02-2005	Fox et al.	715/825
*	E	US-2005/0075119 A1	04-2005	Sheha et al.	455/456.6
*	F	US-6,941,359 B1	09-2005	Beaudoin et al.	709/221
*	G	US-2005/0257400 A1	11-2005	Sommerer et al.	036/013
*	H	US-7,210,094 B2	04-2007	Dovin et al.	715/240
*	I	US-7,216,303 B2	05-2007	Aggarwal et al.	715/825
*	J	US-7,225,407 B2	05-2007	Sommerer et al.	715/738
*	K	US-7,707,506 B2	04-2010	Weigel et al.	715/738
*	L	US-7,725,836 B2	05-2010	Moehrle, Armin	715/811
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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